

Update analysis of TPC detector prototype using UV laser tracks

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Overview

1 TPC detector with UV laser

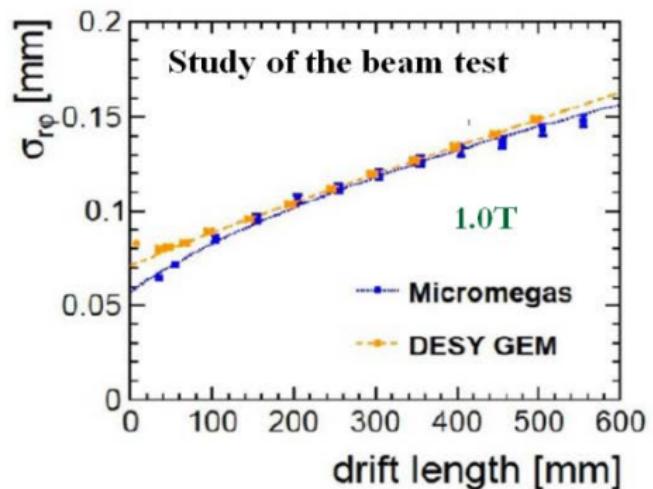
2 dE/dx resolution

3 New electronic testing

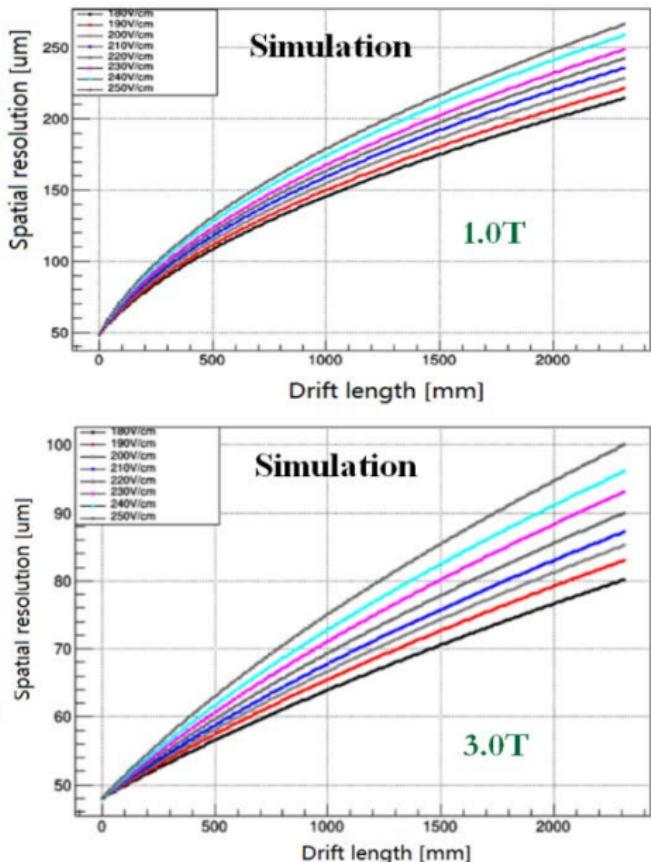
Motivation- spatial resolution

$$\frac{\sigma_{p_\perp}}{p_\perp} = \sqrt{\left(\frac{\alpha' \sigma_x}{BL^2}\right)^2 \left(\frac{720}{N+4}\right) p_\perp^2 + \left(\frac{\alpha' C}{BL}\right)^2 \frac{10}{7} \left(\frac{X}{X_0}\right)}$$

measurements multiple scattering



Large prototype@1.0T from LCTPC



Motivation- Particle identification

$$\sigma_{dE/dx} = \sigma_0 N_{hits}^{-k}$$

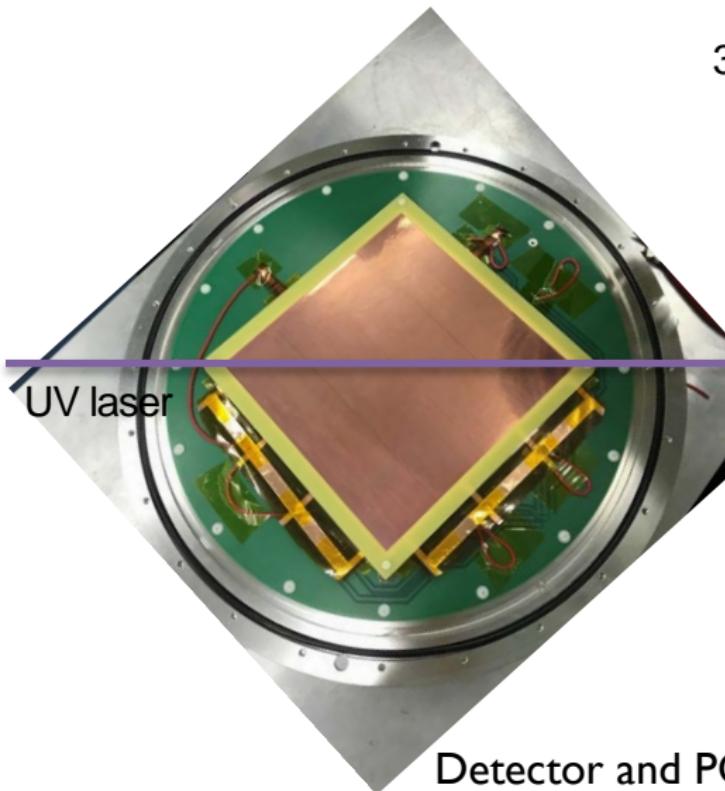
Experiment	Readout	Points	Sample	$p(GeV/c)$	$(\sigma_I/I)_{MC}$	$(\sigma_I/I)_{exp}$
Pad (mm)						
PEP-4 TPC	4	183	e	14.5	2.6%	3.5%
TOPAZ TPC	4	175	π	0.4-0.6	3.8%	4.5%
DELPHI TPC	4	192	π	0.4-0.6	5.4%	6.2%
ALEPH TPC	4	344	e	45.6	3.0%	4.4%
STAR TPC	12, 20	13,32	π	0.4-0.6	5.3%	6.8%
ALICE TPC	7.5, 10, 15	63,64,32	π	6.0	3.3%	5.0%
TPC for CEPC	1mm×6mm	220	K	5.0	3.1%	
Pixel(μm)						
<u>GridPix</u> <u>TPC for ILD</u>	55×55	9500	e	2.5	/	4.1%

NO magnetic field
NO high energy particle testing beam

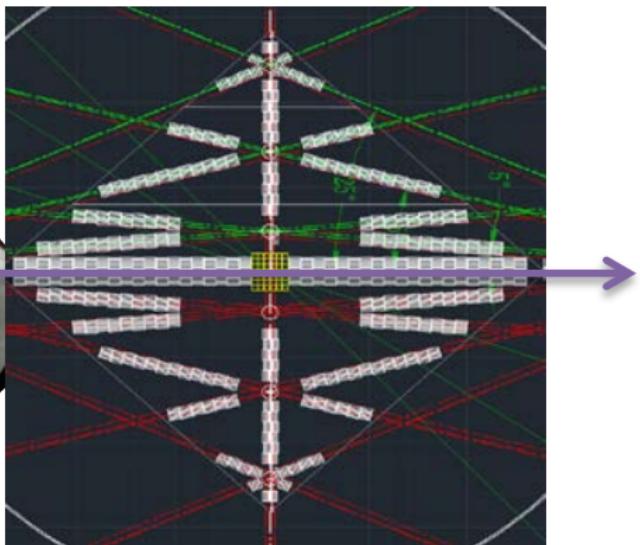


UV lasers (5 years R&D)

TPC detector with UV laser



Pad size: 1mm × 6mm
38 hit points per track by UV laser



Detector and PCB readout board

TPC detector with UV laser

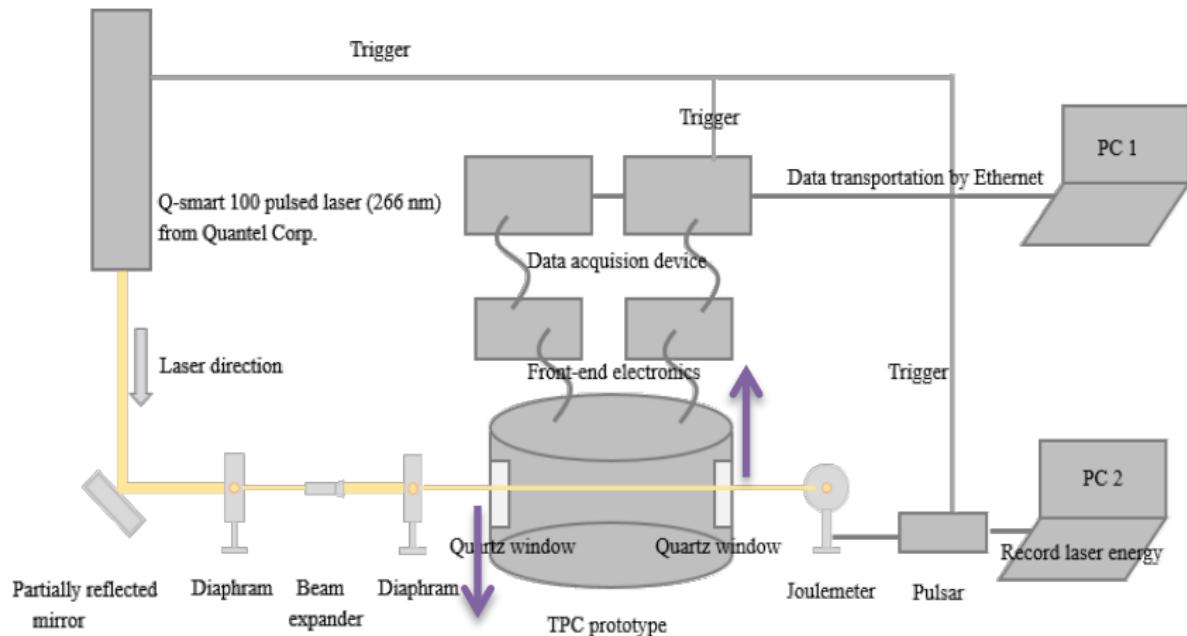
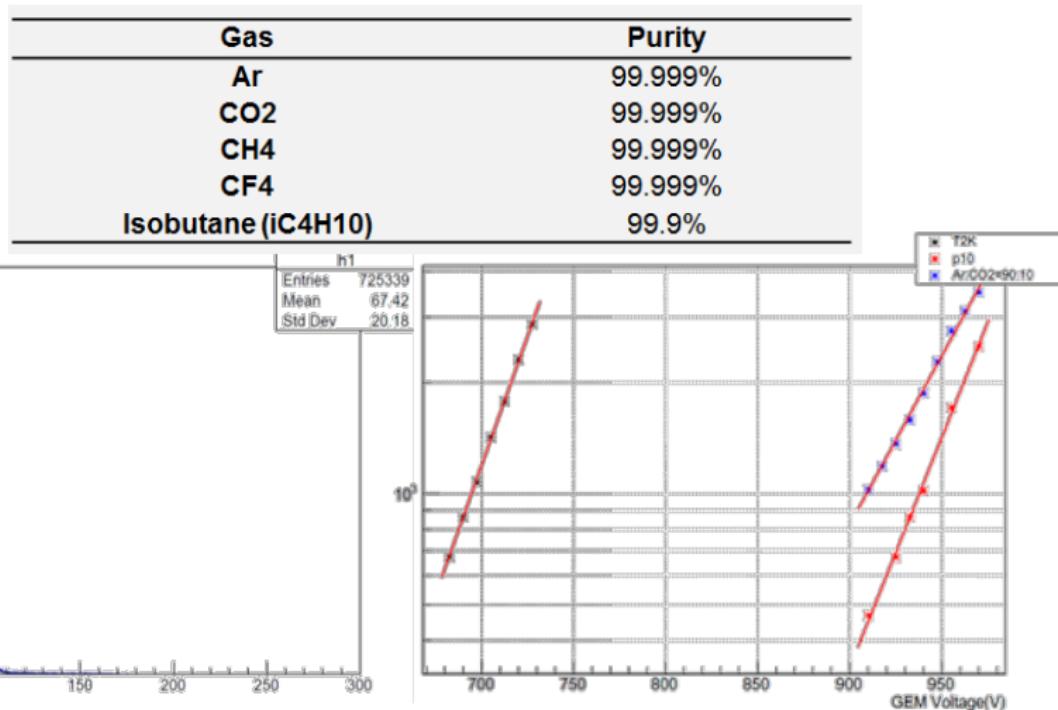


Diagram of TPC detector study

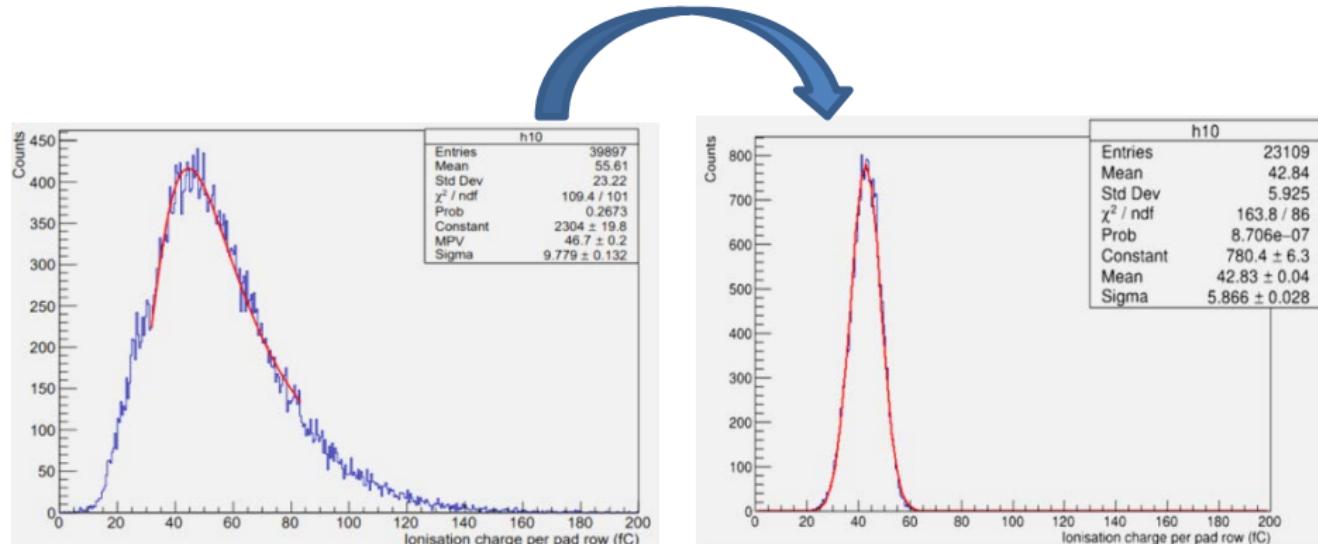
^{55}Fe study



Energy spectrum and gain at T2K/P10/Ar:CO₂

UV laser spectrum - Truncated method

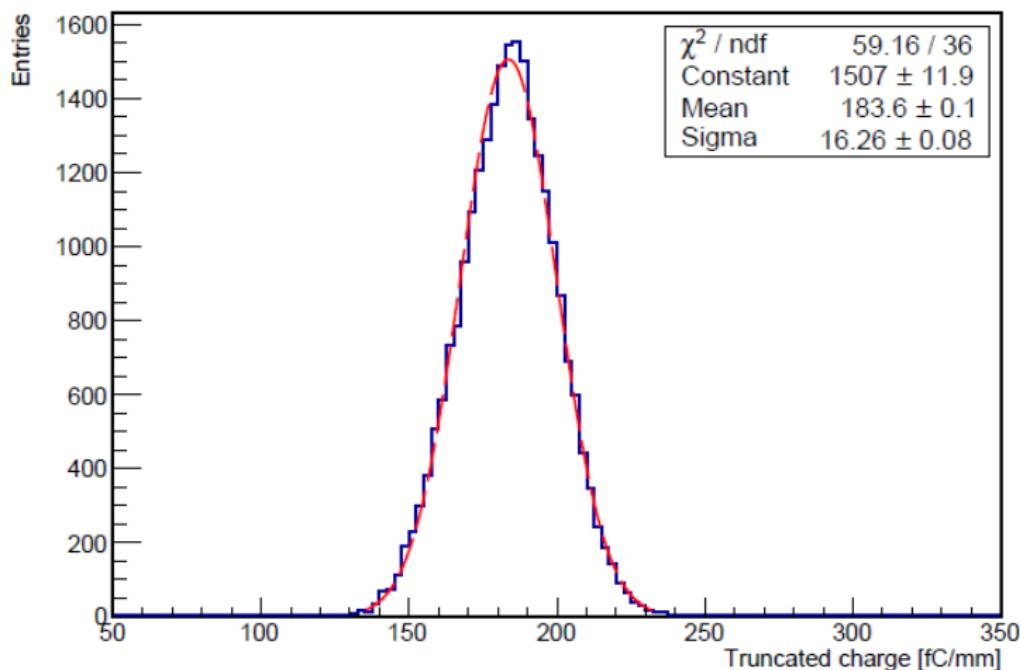
Energy cutting and correction by the events



Energy spectrum of UV

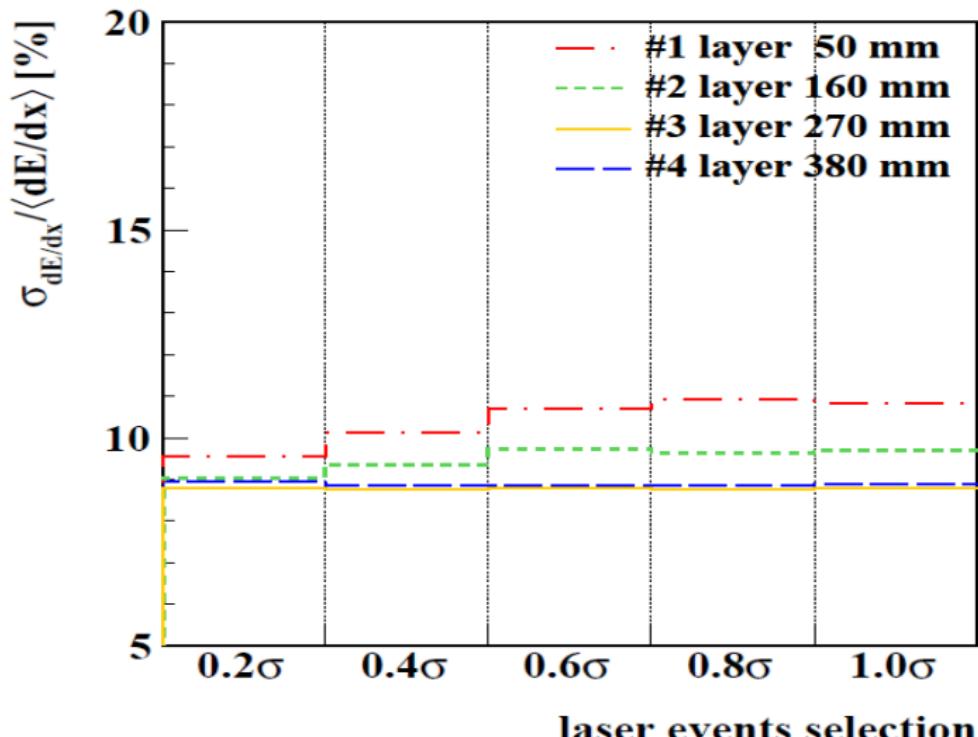
dE/dx resolution – 38 hit points

$$\sigma_{dE/dx} = (8.9 \pm 0.4) \% \text{ (38 hits)}$$



laser events using energy cutting and correction

dE/dx resolution – along drift length

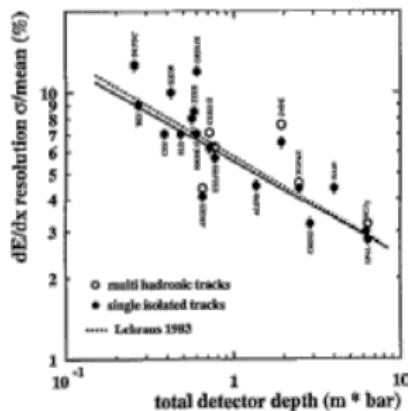


dE/dx resolution along the drift length of TPC prototype

dE/dx resolution - pseudo-tracks using full size

220 points per track
Full size of CEPC TPC concept

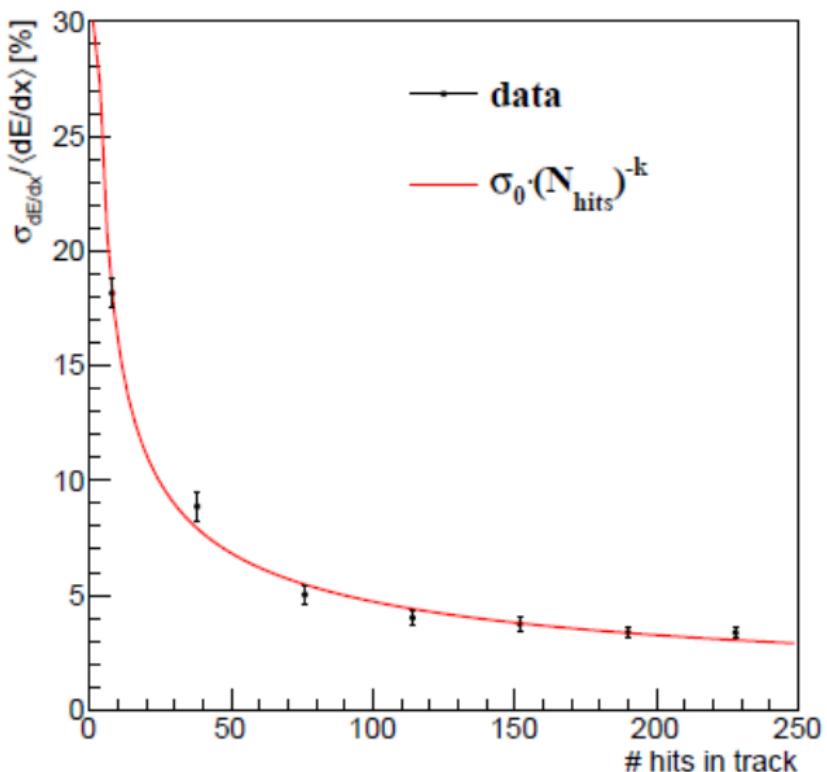
$$\frac{\langle dE / dx \rangle}{\sigma(dE / dx)}$$



Hauschild's formula
Walenta's formula

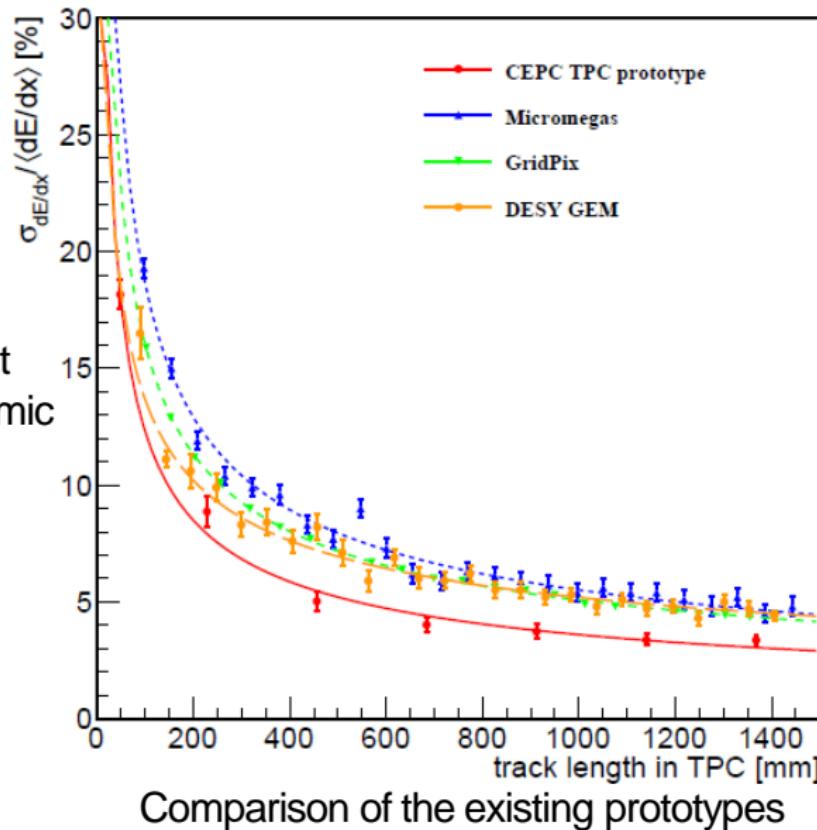
$$\frac{\sigma(dE / dx)}{dE / dx} = 5.5 \times L^{-0.36} \text{ (%)}$$
$$\frac{\sigma(dE / dx)}{dE / dx} = 5.57 \cdot L^{-0.30} \text{ (%)}$$

dE/dx resolution - pseudo-tracks of the different hit points



dE/dx resolution with the pseudo-tracks of the various lengths

dE/dx resolution – comparison of the existing prototypes

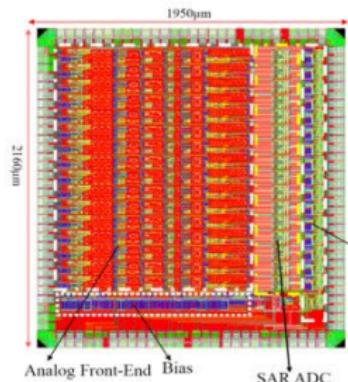


Next steps:

Scanning the different UV laser power to mimic the different primary electrons (and N_{eff})

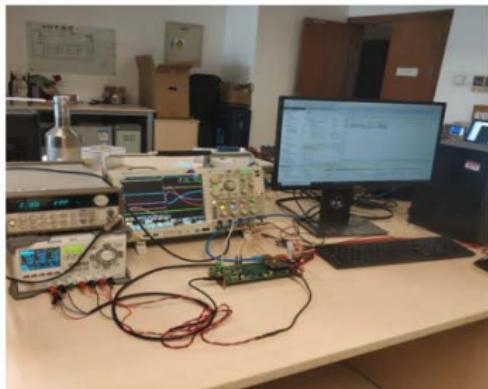
Preparing the publications

Low power ASIC chip



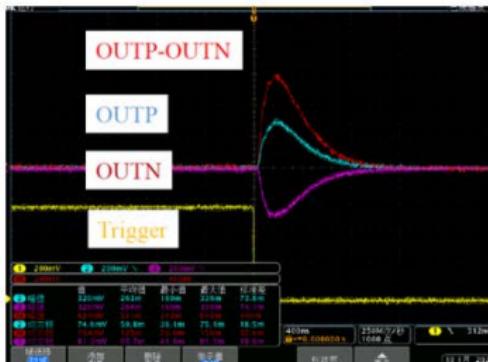
Layout of ASIC chip

- The floor plan in layout :
 - The die size of 1950 μm x 2160 μm
 - Analog Front-End , SPI, SAR ADC, LVDS driver are supplied by separate power
- The ASIC have been taped out in November, 2019 and is being evaluated



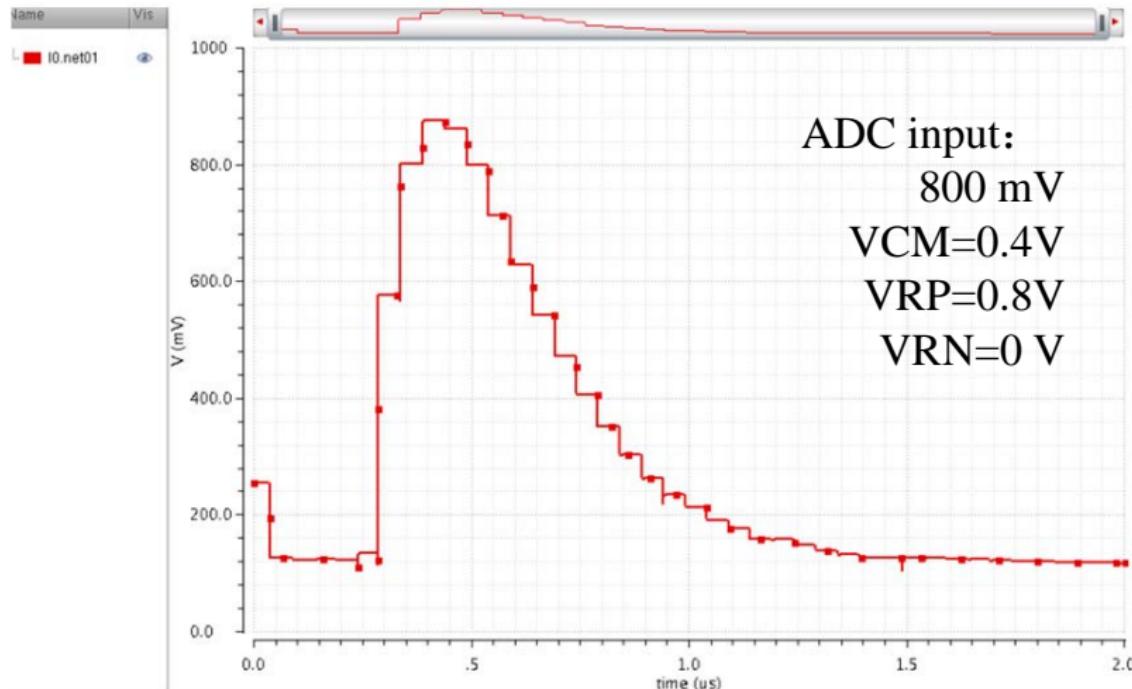
ASIC chip for TPC readout have been developed

- The power consumption is **2.33 mW/channel**
 - $P_{\text{AFE}} = 1.43 \text{ mW}/\text{channel}$
 - $P_{\text{ADC}} = 0.9 \text{ mW}/\text{channel} @ 40\text{M/s}$
- $\text{ENC} = 852\text{e} @ C_m = 2\text{pF}$, gain = **10 mV/fC** and can be reduced to **474e** using digital trapezoidal filter



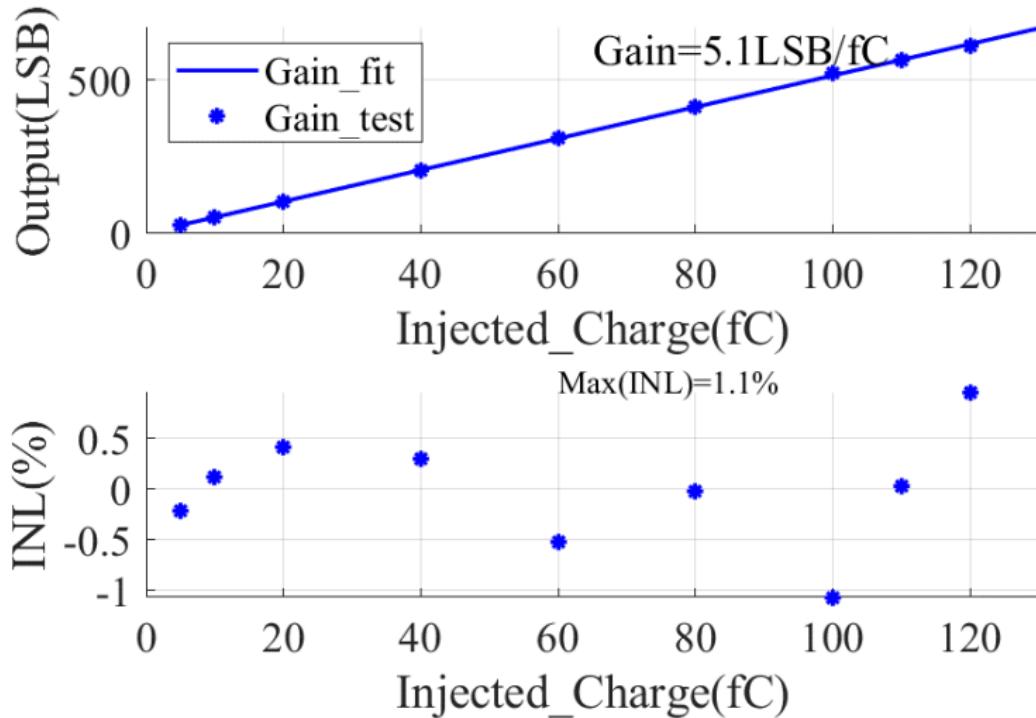
Test of the signals

Low power ASIC chip- ADC simulation

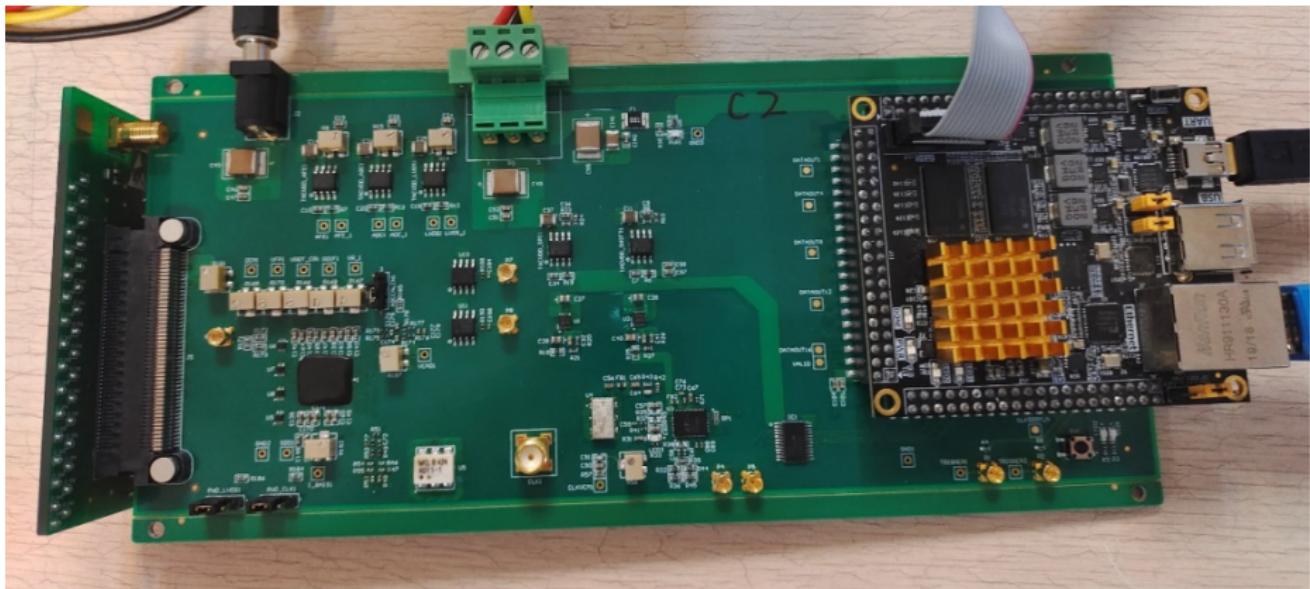


$$1 \text{ LSB} = 1600 \text{ mV} / 1024 = 1.56 \text{ mV}$$

Low power ASIC chip- Integral Nonlinearity



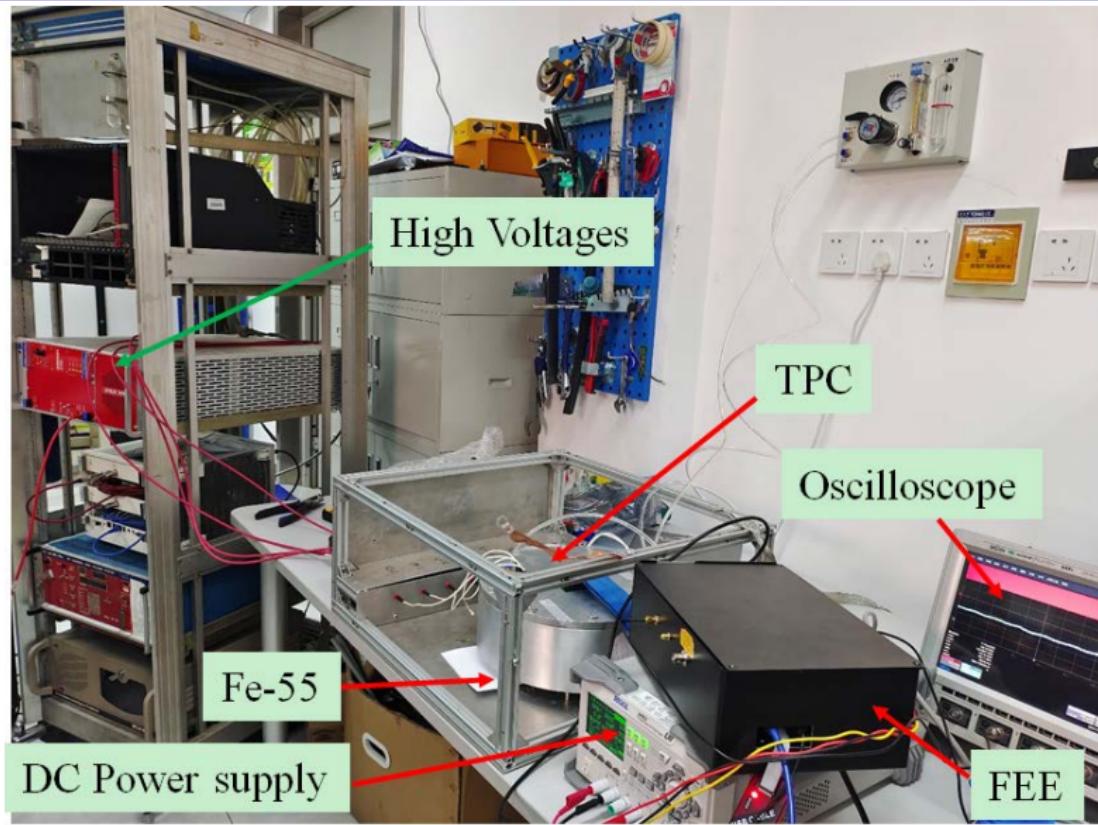
Low power ASIC chip- WASA_V0 testing board



Channels: ≤ 128 channels (64 channels available)

External power supply: $\pm 5V$, $\pm 12V$, $\pm 24V$

Low power ASIC chip- WASA_V0 testing



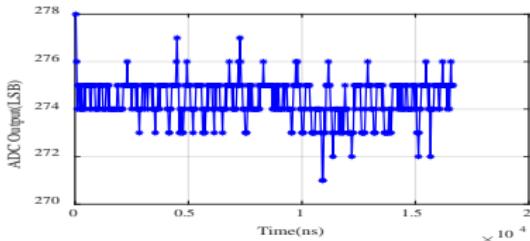
Low power ASIC chip- WASA_V0 testing

Testing parameters:

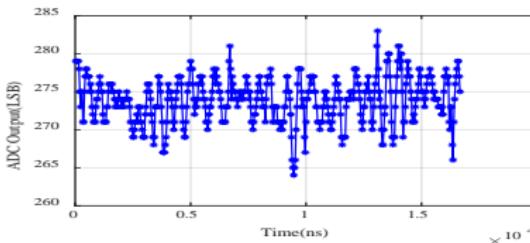
- GEMs detector: 280V-310 V
- E_{drift} : ≤ 280 V/cm
- Operation gases: Ar/CF₄/iC₄H₁₀ 95/3/2 (T2K)
- Radioactive source: ⁵⁵Fe@ 1mCi

Low power ASIC chip- Baseline of the noise

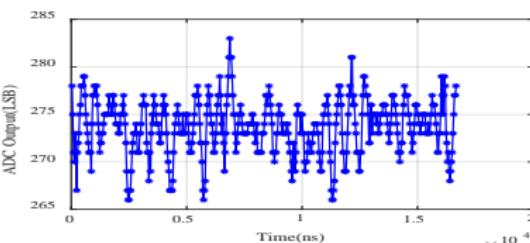
Baseline of the noise
without detector connecting



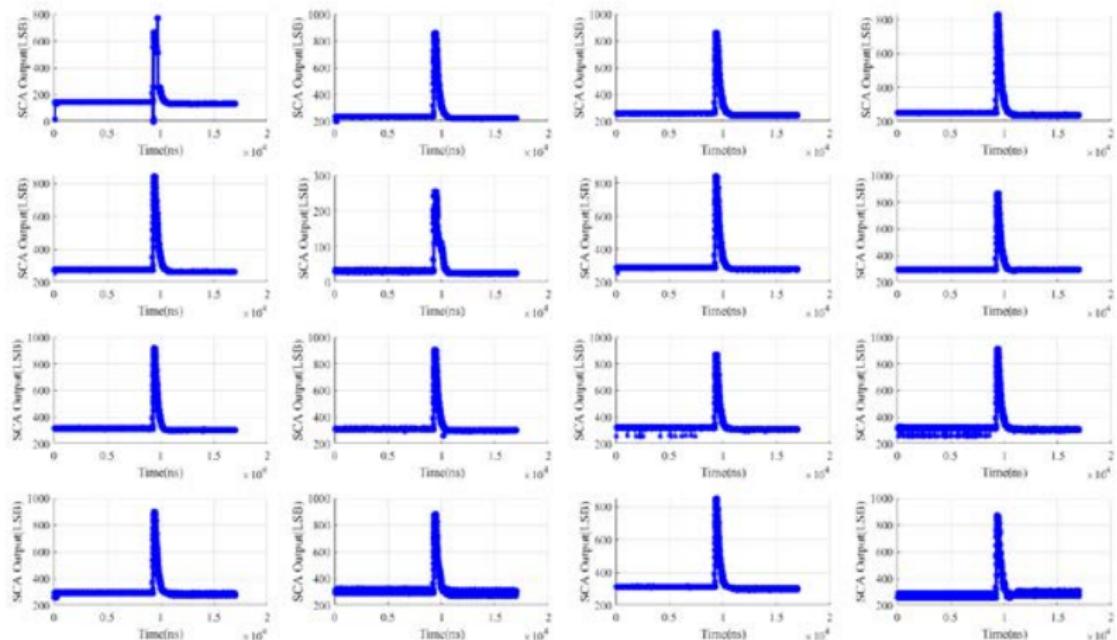
Baseline of the noise
with TPC detector connecting
@ $V_{GEM}=0V$ @ $E_{drift}=0V/cm$



Baseline of the noise
with TPC detector connecting
@ $V_{GEM}=310V$ @ $E_{drift}=290V/cm$



Low power ASIC chip- WASA_V0 testing



16 channels output waveform

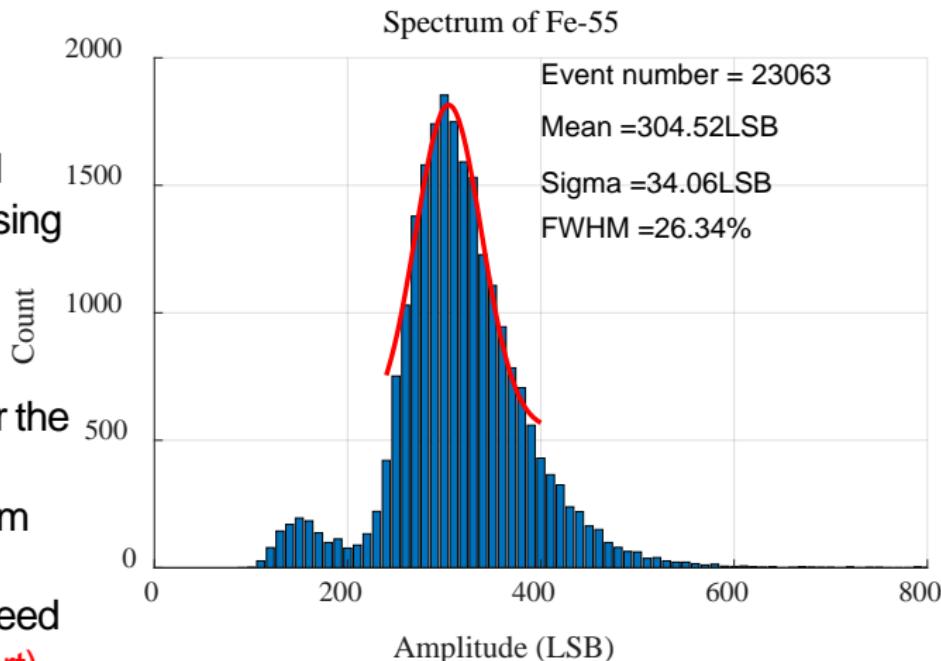
Low power ASIC chip- preliminary results

^{55}Fe testing:

Successfully
commissioned and
collected signals using
DAQ

Next steps:

Using collimator for the
radioactive source
and taking data from
more channels
and new DAQ to need
(NO funding support)



Summary

- dE/dx study used TPC detector using 266nm UV laser
- ^{55}Fe and UV laser's energy spectrum and gain measured
- Pseudo-tracks with 220 layers and dE/dx can reach to $3.36 \pm 0.26\%$ of dE/dx by Pad size ($1\text{mm} \times 6\text{mm}$)
- Successfully testing and collected signals using the new electronics with the lower power consumption chips

Thanks